Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

#### <sup>I</sup>description

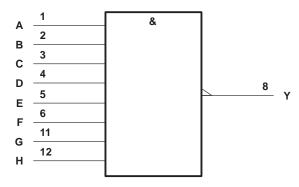
These devices contain a single 8-input NAND gate. They perform the Boolean functions  $Y = \overline{A} \cdot \overline{B} \cdot \overline{C} + \overline{D} + \overline{E} + \overline{F} + \overline{G} + \overline{H}$  in positive logic.

The SN54F30 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to 125°C. The SN74F30 is characterized for operation from 0°C to 70°C.

**FUNCTION TABLE** 

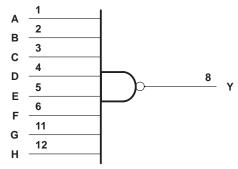
INPUTS A-H	OUTPUT Y					
All inputs H	L					
One or more inputs L	Н					

### logic symbol†

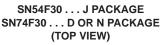


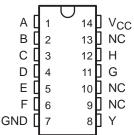
<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

## logic diagram (positive logic)

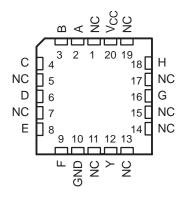


Pin numbers shown are for the D, J, and N packages.

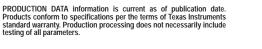




SN54F30 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection





SDFS043A - MARCH 1987 - REVISED OCTOBER 1993

# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)	1.2 V to 7 V
Input current range	30 mA to 5 mA
Voltage range applied to any output in the high state	0.5 V to V <sub>CC</sub>
Current into any output in the low state	40 mA
Operating free-air temperature range: SN54F30	–55°C to 125°C
SN74F30	0°C to 70°C
Storage temperature range	-65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

		SN54F30			SN74F30			UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V	
VIH	High-level input voltage	2			2			V	
VIL	Low-level input voltage			0.8			0.8	V	
ΙΙΚ	Input clamp current			-18			-18	mA	
ІОН	High-level output current			- 1			- 1	mA	
l <sub>OL</sub>	Low-level output current			20			20	mA	
T <sub>A</sub>	Operating free-air temperature	-55		125	0		70	°C	

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		;	SN54F30			SN74F30			
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT	
VIK	V <sub>CC</sub> = 4.5 V,	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V	
Vari	$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -1 \text{ mA}$	2.5	3.4		2.5	3.4		V	
VOH	$V_{CC} = 4.75 \text{ V},$	$I_{OH} = -1 \text{ mA}$				2.7			V	
$V_{OL}$	$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 20 \text{ mA}$		0.3	0.5		0.3	0.5	V	
IJ	$V_{CC} = 5.5 V,$	V <sub>I</sub> = 7 V			0.1			0.1	mA	
lіН	$V_{CC} = 5.5 \text{ V},$	$V_{I} = 2.7 V$			20			20	μΑ	
I <sub>IL</sub>	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.5 V			- 0.6			- 0.6	mA	
l <sub>OS</sub> §	V <sub>C</sub> C = 5.5 V,	V <sub>O</sub> = 0	-60		-150	-60		-150	mA	
ICCH	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0		0.7	1.5		0.7	1.5	mA	
ICCL	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 4.5 V		2.2	4		2.2	4	mA	

<sup>‡</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



NOTE 1: The input voltage ratings may be exceeded provided the input current ratings are observed.

<sup>§</sup> Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

SDFS043A - MARCH 1987 - REVISED OCTOBER 1993

# switching characteristics (see Note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 5 V, C <sub>L</sub> = 50 pF, R <sub>L</sub> = 500 Ω, T <sub>A</sub> = 25°C			$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$ $C_L = 50 \text{ pF},$ $R_L = 500 \Omega,$ $T_A = \text{MIN to MAX}^{\dagger}$ SN54F30 SN74F30				UNIT
			MIN	′F30 TYP	MAX	MIN	MAX	SN74 MIN	MAX	
<sup>t</sup> PLH	A thru H	V	1	3.1	5	1	6	1	5.5	ns
<sup>t</sup> PHL		'	1	2.6	4.5	1	6	1	5	115

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. NOTE 2: Load circuits and waveforms are shown in Section 1.

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